

Features

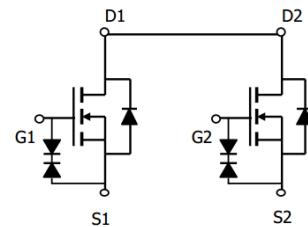
- Dual N-Channel, 2.5V Logic Level Control
- Low on-resistance $R_{DS(on)}$ @ $V_{GS}=2.5$ V
- Fast Switching
- ESD Protection HBM 2.5KV
- Pb-free lead plating; RoHS compliant

V_{DS}	20	V
$R_{DS(on),TYP} @ V_{GS}=4.5$ V	19	$m\Omega$
$R_{DS(on),TYP} @ V_{GS}=2.5$ V	26	$m\Omega$
I_D	7	A

TSSOP8

Halogen-Free

Part ID	Package Type	Marking	Tape and reel information
VS8810DTS	TSSOP8	8810D	3000PCS/Reel


Maximum ratings, at $T_A = 25^\circ C$, unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	20	V
I_s	Diode continuous forward current	$T_A = 25^\circ C$	A
I_D	Continuous drain current @ $V_{GS}=4.5V$	$T_A = 25^\circ C$	A
		$T_A = 100^\circ C$	A
I_{DM}	Pulse drain current tested ①	$T_A = 25^\circ C$	A
P_D	Maximum power dissipation	$T_A = 25^\circ C$	W
V_{GS}	Gate-Source voltage	± 8	V
$T_{STG} T_J$	Storage and operating temperature range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JL}$	Thermal Resistance-Junction to Lead	70	°C/W
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	83.5	°C/W

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ $T_j=25^\circ\text{C}$ (unless otherwise stated)						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	20	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=20\text{V}, V_{\text{GS}}=0\text{V}$	--	--	1	μA
	Zero Gate Voltage Drain Current($T_j=125^\circ\text{C}$)	$V_{\text{DS}}=20\text{V}, V_{\text{GS}}=0\text{V}$	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 8\text{V}, V_{\text{DS}}=0\text{V}$	--	--	± 10	μA
$V_{\text{GS}(\text{TH})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	0.4	0.8	1.2	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance②	$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=6\text{A}$	--	19	25	$\text{m}\Omega$
$R_{\text{DS}(\text{ON})}$	Drain-Source On-State Resistance②	$V_{\text{GS}}=2.5\text{V}, I_{\text{D}}=5\text{A}$	--	26	34	$\text{m}\Omega$
Dynamic Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (unless otherwise stated)						
C_{iss}	Input Capacitance	$V_{\text{DS}}=10\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	300	415	500	pF
C_{oss}	Output Capacitance		40	90	140	pF
C_{rss}	Reverse Transfer Capacitance		30	80	130	pF
Q_g	Total Gate Charge	$V_{\text{DS}}=10\text{V}, I_{\text{D}}=6\text{A}, V_{\text{GS}}=4.5\text{V}$	--	8.2	--	nC
Q_{gs}	Gate-Source Charge		--	2.4	--	nC
Q_{gd}	Gate-Drain Charge		--	3.3	--	nC
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{DD}}=0\text{V}, I_{\text{D}}=6\text{A}, R_{\text{C}}=3.0\Omega, V_{\text{GS}}=4.5\text{V}$	--	6.5	--	nS
t_r	Turn-on Rise Time		--	8	--	nS
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	35	--	nS
t_f	Turn-Off Fall Time		--	9.1	--	nS
Source- Drain Diode Characteristics@ $T_j = 25^\circ\text{C}$ (unless otherwise stated)						
V_{SD}	Forward on voltage	$I_{\text{SD}}=1.6\text{A}, V_{\text{GS}}=0\text{V}$	--	0.8	1.2	V
t_{rr}	Reverse Recovery Time	$T_j=25^\circ\text{C}, I_{\text{sd}}=6\text{A}, V_{\text{GS}}=0\text{V}$ $dI/dt=100\text{A}/\mu\text{s}$	--	15	--	nS
Q_{rr}	Reverse Recovery Charge			5.3		nC

NOTE:

① Repetitive rating; pulse width limited by max. junction temperature.

② Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$

Typical Characteristics

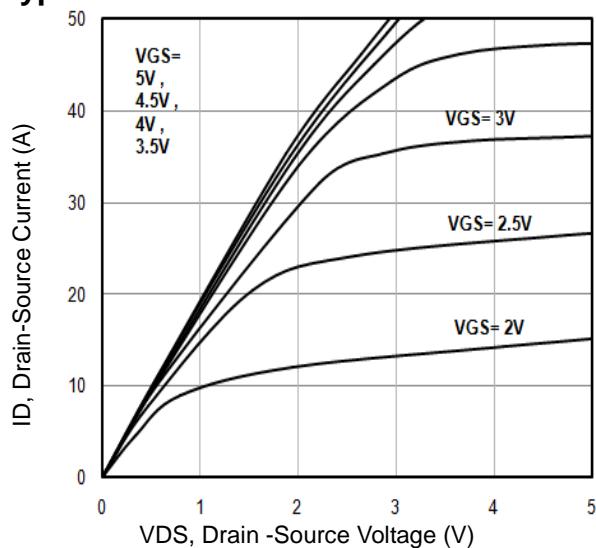


Fig1. Typical Output Characteristics

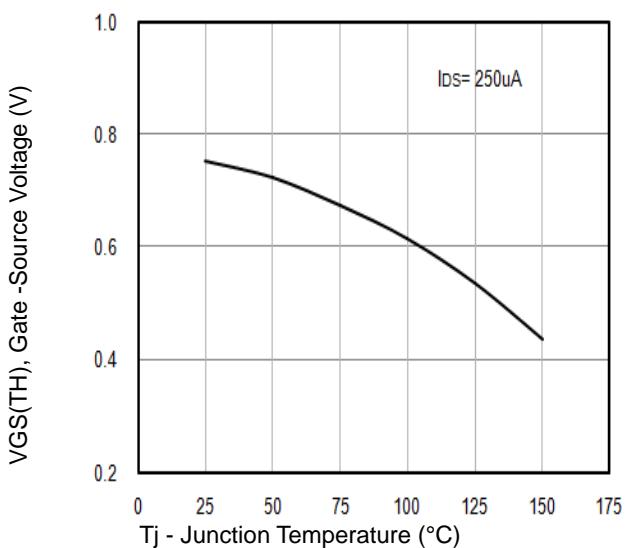


Fig2. $V_{GS(TH)}$ Gate -Source Voltage Vs. T_j

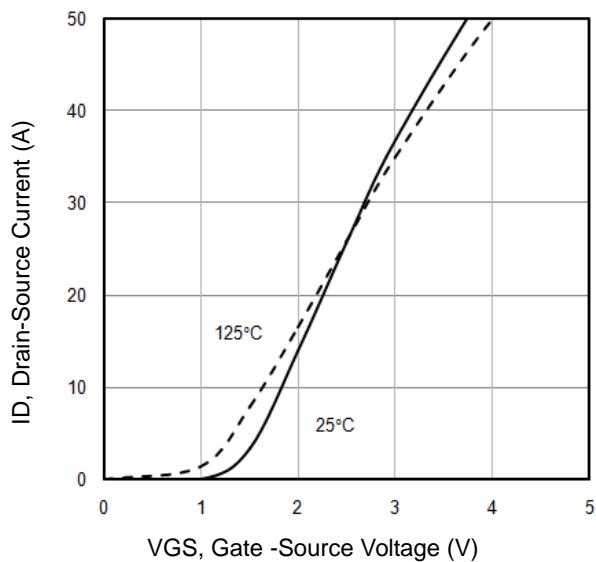


Fig3. Typical Transfer Characteristics

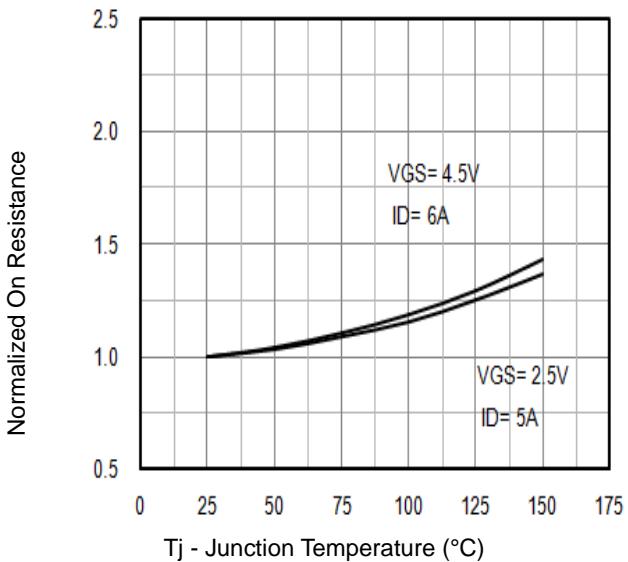


Fig4. Normalized On-Resistance Vs. T_j

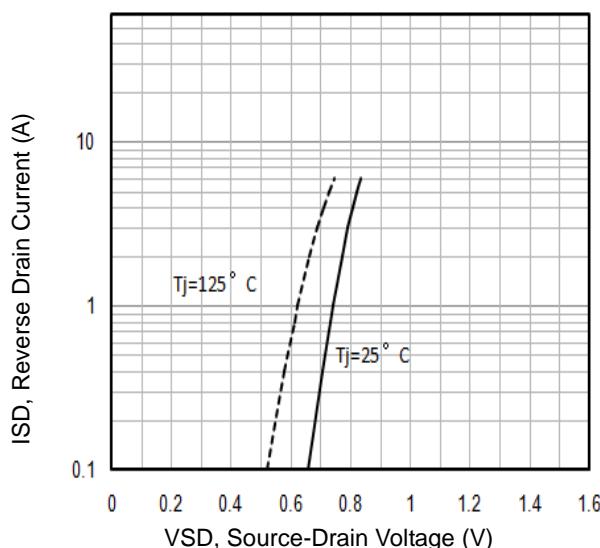


Fig5. Typical Source-Drain Diode Forward Voltage

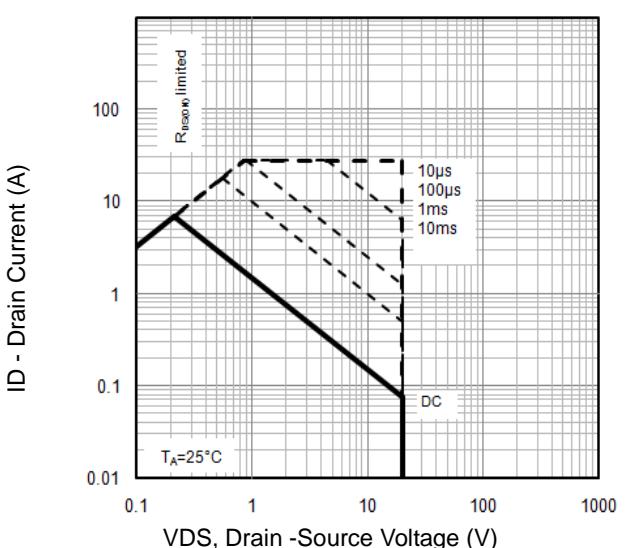


Fig6. Maximum Safe Operating Area

Typical Characteristics

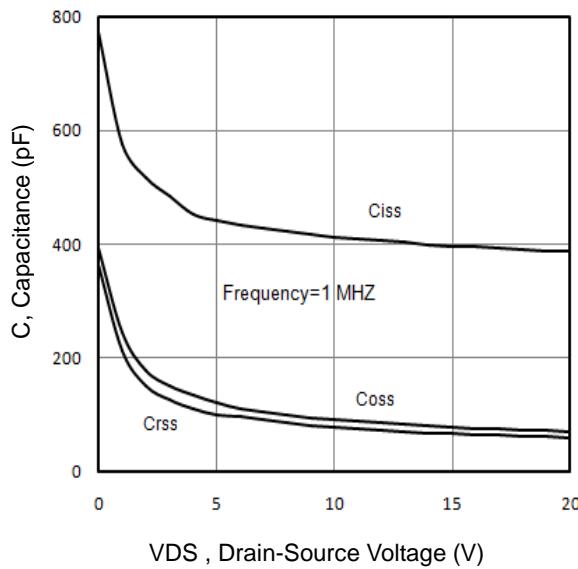


Fig7. Typical Capacitance Vs.Drain-Source Voltage

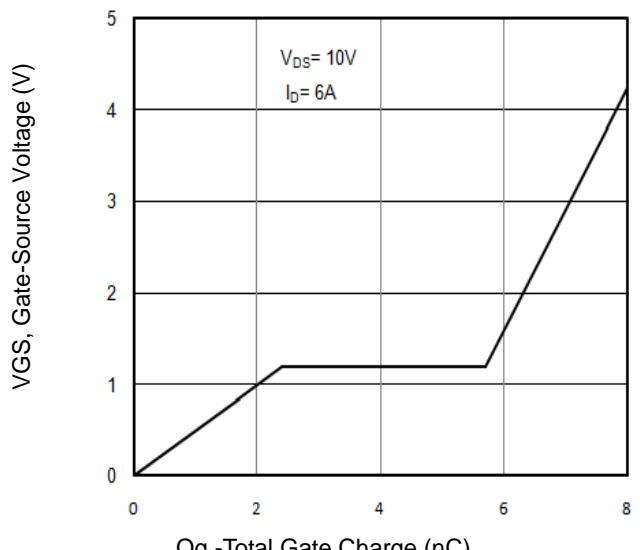


Fig8. Typical Gate Charge Vs.Gate-Source Voltage

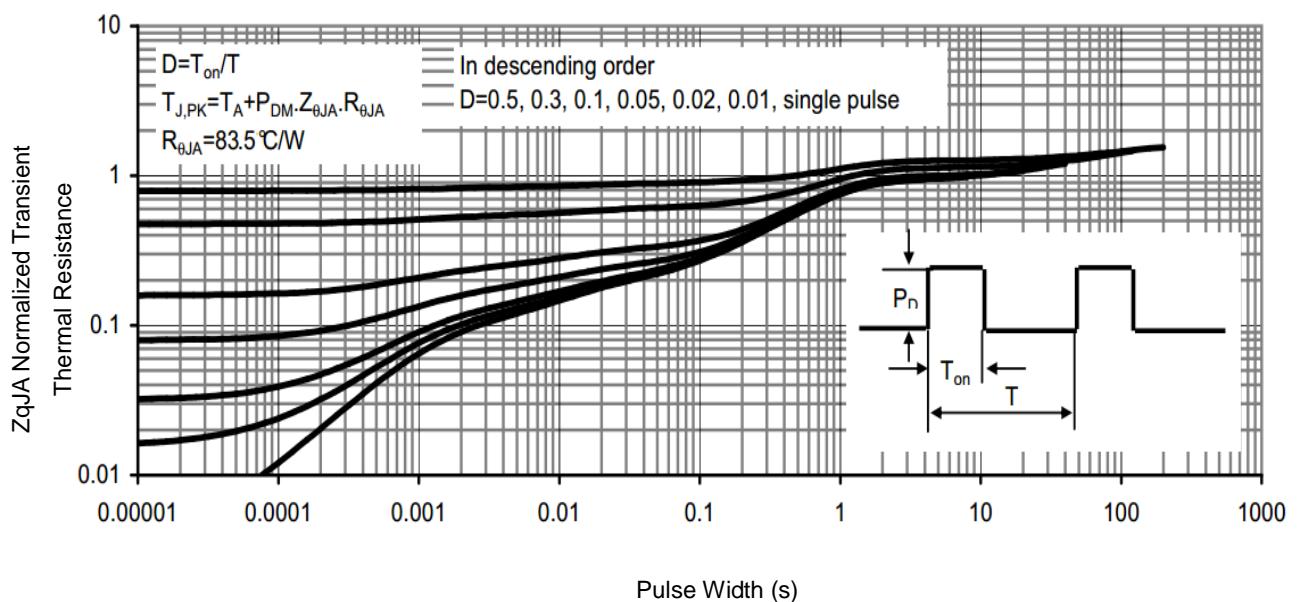


Fig9. Normalized Maximum Transient Thermal Impedance

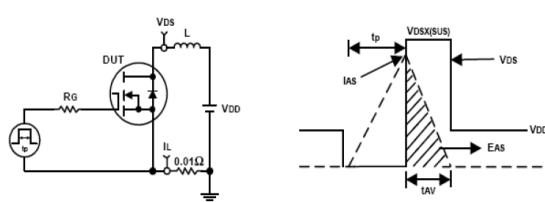


Fig10. Unclamped Inductive Test Circuit and waveforms

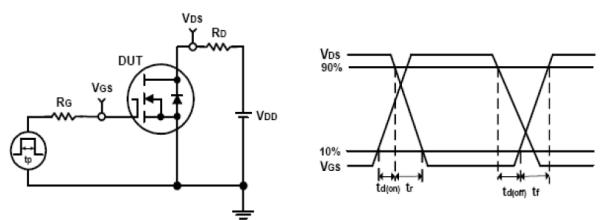
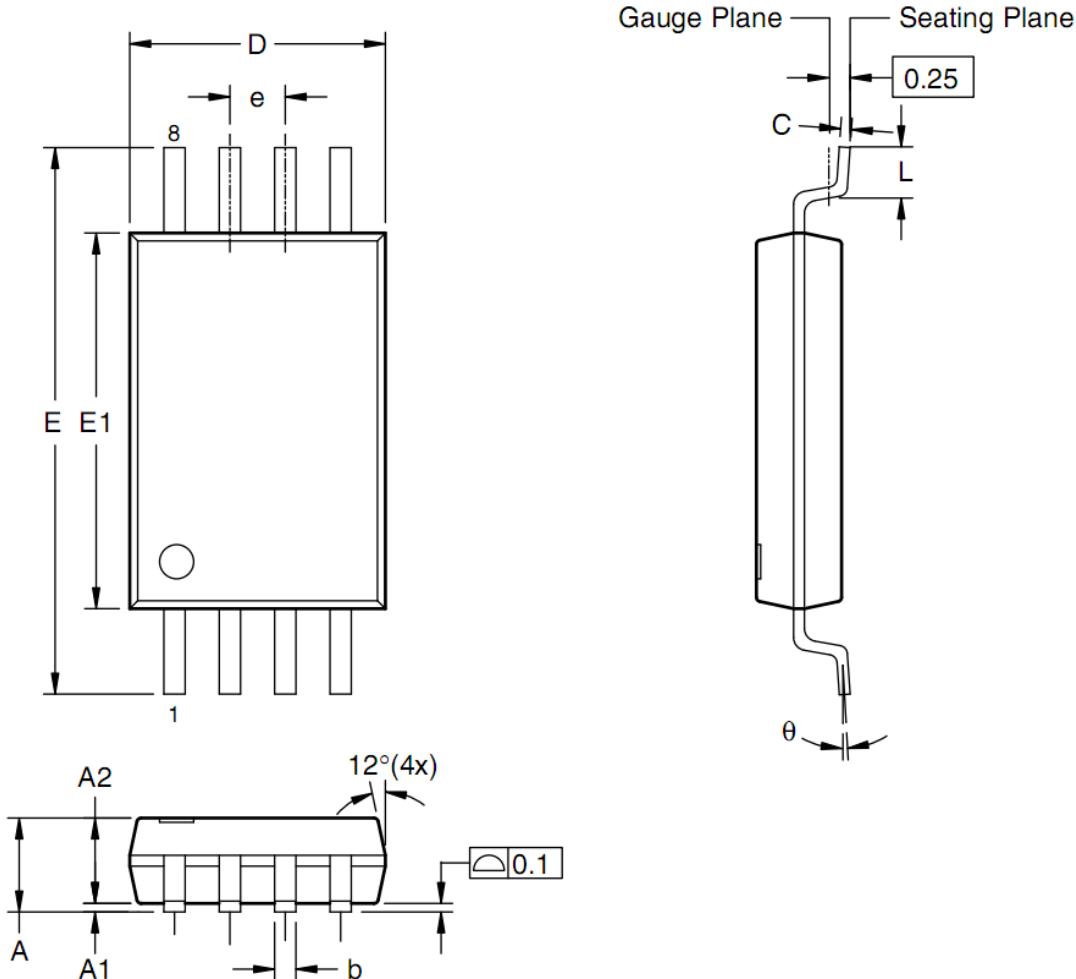


Fig11. Switching Time Test Circuit and waveforms



TSSOP8 Package Outline Data



Symbol	Dimensions (unit: mm)		
	Min	Typ	Max
A	--	--	1.20
A1	0.05	--	0.15
A2	0.80	1.00	1.05
b	0.19	--	0.30
C	0.09	--	0.20
D	2.90	3.00	3.10
E	6.40 BSC		
E1	4.30	4.40	4.50
e	0.65 BSC		
L	0.45	0.60	0.75
θ	0°	--	8°

Notes:

1. Refer to JEDEC MO-153 (AA)
2. Dimension "D" does NOT include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15mm per side.
3. Dimension "E1" does NOT include interlead flash or protrusion. Interlead flash or protrusion shall not exceed 0.25mm per side.

Customer Service

Sales and Service:

sales@vgsemi.com

Vanguard Semiconductor CO., LTD

TEL: (86-755) -26902410

FAX: (86-755) -26907027

WEB: www.vgsemi.com